

Search Notes

Application/Control No.

10/768,543

Examiner

Winnie Yip

Applicant(s)/Patent under
Reexamination

FOUST ET AL.

Art Unit

3636

SEARCHED

Class	Subclass	Date	Examiner
52	167.1 223.4 295 720.1	7/21/2006	WSY
	721.2		
	721.4		
	723.1		
	736.1		
	736.3		
	742.14		
✓	741.14		
264	35 228 310		
425	111 126		
✓	289 137.1		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Text Searched in EAST	7/23/2006	WSY